



UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
 United States Patent and Trademark Office
 Address: COMMISSIONER FOR PATENTS
 P.O. Box 1450
 Alexandria, Virginia 22313-1450
 www.uspto.gov

BIB DATA SHEET

CONFIRMATION NO. 5607

SERIAL NUMBER	FILING or 371(c) DATE RULE	CLASS	GROUP ART UNIT	ATTORNEY DOCKET NO.
10/593,830	09/22/2006	382	2829	296431US2PCT

APPLICANTS
 Hisao Igarashi, Chuo-Ku, JAPAN;
 Katsumi Sato, Chuo-Ku, JAPAN;
 Kazuo Inoue, Chuo-Ku, JAPAN;

**** CONTINUING DATA *******
 This application is a 371 of PCT/JP05/06108 03/30/2005

**** FOREIGN APPLICATIONS *******
 JAPAN 2004-102948 03/31/2004

**** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ****
 04/26/2007

Foreign Priority claimed 35 USC 119(a-d) conditions met Verified and Acknowledged	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No /MINH NHUT TANG/ Examiner's signature	<input type="checkbox"/> Met after Allowance MT Initials	STATE OR COUNTRY JAPAN	SHEETS DRAWINGS 8	TOTAL CLAIMS 12	INDEPENDENT CLAIMS 2
---	--	--	------------------------------	-------------------------	-----------------------	----------------------------

ADDRESS
 OBLON, SPIVAK, MCCLELLAND MAIER & NEUSTADT, P.C.
 1940 DUKE STREET
 ALEXANDRIA, VA 22314
 UNITED STATES

TITLE
 Probe apparatus, wafer inspecting apparatus provided with the probe apparatus and wafer inspecting method

FILING FEE RECEIVED 1260	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees
		<input type="checkbox"/> 1.16 Fees (Filing)
		<input type="checkbox"/> 1.17 Fees (Processing Ext. of time)
		<input type="checkbox"/> 1.18 Fees (Issue)
		<input type="checkbox"/> Other _____
		<input type="checkbox"/> Credit